

DC ELECTRICAL CHARACTERIZATION FACILITY (Current – Voltage Measurements)



MODEL: HP 4140B pA METER/DC VOLTAGE SOURCE

INSTALLATION PLACE: DC Electrical Characterization Laboratory (room No14 new-building), Department of Microelectronics

DESCRIPTION:

It consists of an extremely stable pico-ampere meter and 2 programmable DC voltage sources, one of which operates as a ramp and staircase generator as well as a DC source. 3 basic semiconductor measurements: I, I-V and quasi-static C-V.

SPECIFICATIONS

1. Current measurement:
Measurement range: $\pm 0.001 \times 10^{-12} \text{ A} \sim \pm 1.999 \times 10^{-2} \text{ A}$, 11 ranges, auto/manual range selection.
2. DC Voltage source (V_A and V_B)
Voltage range: $0 \sim \pm 10.00\text{V}$, $0 \sim \pm 100.0\text{V}$, 2 ranges (auto-ranging only)
Voltage sweep: Auto (pause available)/Manual
Max. Current Capacity: 10mA
3. C-V measurement:
Measurement range: $0.0\text{pF} \sim 199.9\text{pF}$, $200\text{pF} \sim 1999\text{pF}$, 2 ranges of Auto range

APPLICATIONS

1. Stable pA Measurements
2. Synchronized I-V measurements
3. Quasi-static C-V measurements

CERTIFICATION/ACCREDITATION

The facility is accredited under ISO 17025.

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